

**Search Notes**

Application/Control No.

10/511,540

Examiner

HIEU T. VO

Applicant(s)/Patent under  
Reexamination

YASUI ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
701	109 108 103 102 115	8/31/2006	VH
73	1.06 865.9	8/31/2006	VH
73	117.3	8/31/2006	VH
60	274 276 285	8/31/2006	VH
123	697 676	8/31/2006	VH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/1/2006	VH
PLUS	7/11/2006	VH